Electronic supplementary Information (ESI)

Preparation of Bismuth-doped CsPbBr³ Perovskite Single Crystal for X-ray and Gamma-ray sensing Application

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Figure. S1. Schematic representation of Bismuth doped on the surface of the CsPbBr₃ single crystal by spin coating process.

In this work, based on precursor engineering, we developed a two-step solution processto prepare the bismuthdoped CspbBr₃ single crystal. The top of the BiI₃ layer was coated on top of the CsPbBr₃ single crystals surface by spin coating (0.2mM BiI₃ solution was prepared by dissolving in 1ml of DMF) solution was used to by spin coating, 800 rpm @ 10 sec, repeated two times after that, dried under a vacuum Oven at 100 °C for 6 hours. This allowed partial cation exchange on the single crystal surface. Also, I_3 has a weak field ligand compared to Br₃, which makes it difficult to replace the Br_3 atoms in the pure CsPbBr₃ single crystal.

Bandgap energies obtained as a function of Tauc plot analysis from absorbance, the calculated band gap values are 2.46 and 2.41 eV for the pure CsPbBr₃ and Bi-doped CsPbBr₃ single crystal samples, respectively.

Table. 1 TCSPC lifetime values of the pure CsPbBr₃ and Bi-doped CsPbBr₃ single crystal samples respectively.

Figure S3. Schematic representation of Bi-doped CsPbBr₃ perovskite-based thin film photodetector fabrication. We fabricated Bi-doped CsPbBr₃ thin films by using single crystals dispersed in DMSO and spin-coated on an FTO substrate. were used in photodetectors with FTO/Bi-doped CsPbBr₃ /Au device structure. Different layers of the device were deposited on the pre-cleaned FTO-coated glass slides. The Bi-doped CsPbBr₃ (photosensitizer) single crystals were dispersed in DMSO: DMF. After that, the solution was deposited by spin coating method over the FTO with 800 rpm at 20 seconds, repeated at two times, and dried at ambient temperature for 3 hrs. Au top electrodes was deposited (electrode area (0.25×0.25 cm₂) by using thermal evaporation method. The constructed devices were subjected to photocurrent measurements.

Figure. S4. (a) Room-temperature X-ray diffraction pattern of CsPbBr₃ and Bi-doped CsPbBr₃ single crystal thinfilm samples coated on FTO substrate.

The XRD characterization explores the structural authentication of thinfilm, crystallographic planes, and crystallinity. The powder XRD patterns of synthesised pure CsPbBr₃ and Bi-doped CsPbBr₃ perovskite thin film coated on FTO substrate are shown in **Fig. S4**. As a result, the 2θ peaks were found to be 15.46°, 27.31°, 30.93°, and 64.11° and corresponding planes of (110), (111), (220), and (440) for both CsPbBr₃ and Bi-doped CsPbBr₃ single crystal thin films samples, which are in good agreement with a single crystal. The CsPbBr₃ perovskite thin films exhibit an orthorhombic structure (ICSD 97851) with the Pnma space group, and there is no phase change occurring in the thin film formation.

Figure S5. Time-dependent photocurrent spectra of Bi-doped CsPbBr₃ thin-film photodetectors at bias 5V and 2V under different wavelength LED source 470 nm and 530 nm (The LED source intensity with 0.3 A input power).

The photoresponsivity (R) is the ratio of the photogenerated current density to that incident light (at given (wavelength) λ~470 nm and 530 nm.

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R = \frac{\Delta I}{PA}
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Where ΔI is the corresponding change in dark and illuminated current and P is the light's power density (or illumination intensity). The value of the responsivity is calculated for the photodetector at two different wavelength and tabulated in Table.1

Table. 2 Calculated value of the responsivity of the Bi-doped CsPbBr₃ thin film sample at 5v bias.